Exercise 2 time to defect delay time

X ~ Uniform H ~ Exponential (1) The probability of failure renewal. in a certain inspection interval $((i-1)\tau, i\tau)$: $\int_{(i-1)\tau}^{i\tau} f_X(u) F_H(i\tau-u) du$ = $\int_{(i-1)^2}^{i^2} \frac{1}{10} (1 - \exp(-\lambda(i^2 - \omega))) du$ (when o≤ (i-1)t∈ it≤10) otherwise it equals 0 The probability of inspection renewal with replacement at time point Siz fx(u) (1-FH(iz-u)) du (it): = $\int_{(i-1)\tau}^{i\tau} \frac{1}{10} \exp(-\lambda(i\tau-\nu)) d\nu$ (when 0<(i-1)z < iz<10) otherwise it equals 0 $E(CL) = \sum_{i=1}^{\infty} \left\{ \int_{(i-1)x}^{i7} t \int_{(i-1)x}^{i7} f_{x}(u) f_{H}(t-u) du dt + \right\}$ $iZ\int_{(i-1)x}^{iZ} f_{x}(w)(1-F_{H}(iZ-w))du^{2} \qquad (lecture note equation (7))$ $= \lfloor \frac{10}{2} \rfloor \int_{(i-1)x}^{iZ} t \int_{(i-1)x}^{iZ} \frac{1}{(i-1)x} \lambda \exp(-\lambda(t-w)) dudt +$ ir sir to exp(-2(ir-u)) du 3 (periods before + SLL21+1)2 + SLL212 + SLL212 (LL21+DZ) dudt + $Z([-1]) = \frac{10}{10} = \frac{10}{$

For the renewal cycle cost, when failure renewal happens, the renewal cycle cost is the sum of the inspection cost (2-1) Ci and. the corrective maintenance cost Ccm.

Then the experted cycle cost due to failure renewals is

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((i-1)Ci+(cm)) iz fx(u)FH(iz-u)du} (lecture note equation (8))

= \(\frac{10}{12}\) \{ \(\left(\frac{1}{1}-\right)\) \(\left(\frac{1}{1}-\right)\) \(\frac{1}{12}\) \(\frac{

When the inspection renewal happens at time point it, the remend agove use equals the sum of the inspertion cost it and the preventre maintenance cost Cpm.

preventive maintenance cost upm.

Then the expected cycle cost due to inspection renewals is $\sum_{i=1}^{\infty} \left(i \cdot C_i + C_{pm} \right) \int_{(i-1)^{-1}}^{i^{-1}} f_{x}(u) \left(1 - F_{H} \left(i \cdot z - u \right) \right) du \right\} \left(\text{lecture note} \right)$ $= \sum_{i=1}^{\infty} \left(i \cdot C_i + C_{pm} \right) \int_{(i-1)^{-1}}^{i^{-1}} f_{x}(u) \left(1 - F_{H} \left(i \cdot z - u \right) \right) du \right\}$ $= \sum_{i=1}^{\infty} \left(i \cdot C_i + C_{pm} \right) \int_{(i-1)^{-1}}^{i^{-1}} \frac{1}{C_i} \exp \left(-\lambda \left(\frac{1}{C_i} \right) + 1 \right) z - u \right) du$ $+ \left(\left(\frac{1}{C_i} \right) + 1 \right) \left(i + C_{pm} \right) \int_{(i-1)^{-1}}^{1} \frac{1}{C_i} \exp \left(-\lambda \left(\frac{1}{C_i} \right) + 1 \right) z - u \right) du$ Then $+ \left(\left(\frac{1}{C_i} \right) + 1 \right) \left(i + C_{pm} \right) \int_{(i-1)^{-1}}^{1} \frac{1}{C_i} \exp \left(-\lambda \left(\frac{1}{C_i} \right) + 1 \right) z - u \right) du$ Then $+ \left(\left(\frac{1}{C_i} \right) + 1 \right) \left(i + C_{pm} \right) \int_{(i-1)^{-1}}^{1} \frac{1}{C_i} \exp \left(-\lambda \left(\frac{1}{C_i} \right) + 1 \right) z - u \right) du$ Then $+ \left(\left(\frac{1}{C_i} \right) + 1 \right) \left(i + C_{pm} \right) \int_{(i-1)^{-1}}^{1} \frac{1}{C_i} \exp \left(-\lambda \left(\frac{1}{C_i} \right) + 1 \right) z - u \right) du$ Then $+ \left(\left(\frac{1}{C_i} \right) + 1 \right) \left(i + C_{pm} \right) \int_{(i-1)^{-1}}^{1} \frac{1}{C_i} \exp \left(-\lambda \left(\frac{1}{C_i} \right) + 1 \right) z - u \right) du$ Then $+ \left(\left(\frac{1}{C_i} \right) + 1 \right) \left(i + C_{pm} \right) \int_{(i-1)^{-1}}^{1} \frac{1}{C_i} \exp \left(-\lambda \left(\frac{1}{C_i} \right) + 1 \right) z - u \right) du$ Then $+ \left(\left(\frac{1}{C_i} \right) + 1 \right) \left(i + C_{pm} \right) \int_{(i-1)^{-1}}^{1} \frac{1}{C_i} \exp \left(-\lambda \left(\frac{1}{C_i} \right) + 1 \right) z - u \right) du$ Then $+ \left(\left(\frac{1}{C_i} \right) + 1 \right) \left(i + C_{pm} \right) \int_{(i-1)^{-1}}^{1} \frac{1}{C_i} \exp \left(-\lambda \left(\frac{1}{C_i} \right) + 1 \right) z - u \right) du$ Then

Theu, E((() = the expected cycle cost due to failure renewals

+ the expected cycle lost due to inspection renewals.

 $CR(z) = \frac{E(C)}{E(CL)}$

the numerical result will be given in another file. For exams, only the derivation part is required. exercise 3 (Open question.)

Since the defect appears at a later stage for this singlecomponent System, it way be more efficient to have an inspection schedule that has decreasing intervals.

0 time eo defect delay time

In other words, it way be more efficient to have more frequent inspections at a later stage of the life cycle. You take could specify a certain form of inspection schedules. then derive the ECCL) and ECCC) of a renewal cycle. The derivation pare is required for exams.